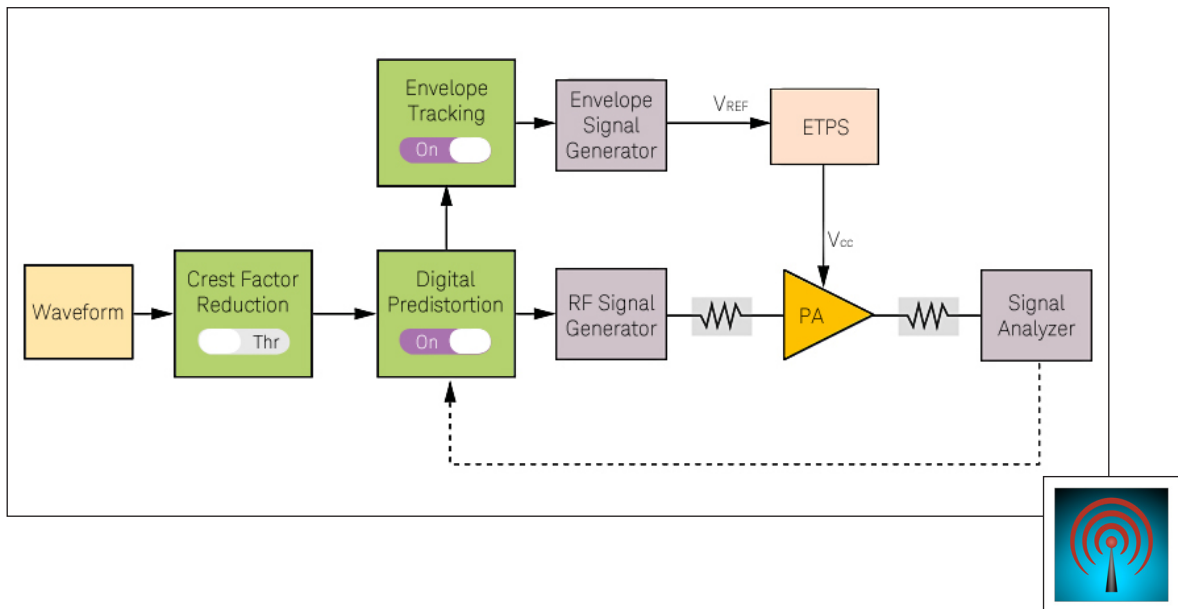


Keysight Technologies

N7614B Signal Studio for Power Amplifier CFR, DPD and ET Test

Technical Overview



- All-in-one test tool for performing power amplifier (PA) test flow with crest factor reduction (CFR), envelope tracking (ET), and digital pre-distortion (DPD). Supports narrow-band, wide-band, and dual-band DPD and ET.
- User-friendly interface for parameter settings, test flow control and instrument control
- Import user-defined I/Q waveforms, signal studio waveforms or free-of-charge pre-loaded waveforms
- PA measurement displays include CCDF, AM-AM, AM-PM, ACP and EVM vs. Power
- DPD supports the open-loop model with Look-Up-Table (LUT), the close-loop model (Volterra and Memory Polynomial), and customer defined DPD algorithms
- Time alignment between the ET signal and the RF signal can be calibrated manually or automatically
- Speed improvement to apply LUT-based DPD and shaping table for ET in real-time

Simplify Signal Creation for PA Test

Keysight Technologies, Inc. Signal Studio software is a flexible test suite of signal-creation and measurement tools that will reduce the time you spend on signal simulation. With the N7614B power amplifier test software, Signal Studio's performance-optimized test flow—validated by Keysight—enhances the characterization and verification of your devices. Through its application-specific user-interface you'll create a test flow with CFR, and/or ET, and/or DPD technologies for power amplifier test.

Modern mobile communications, such as LTE and 802.11ac place new demands on linearity, bandwidth and power consumption in wireless components and place unprecedented battery requirements on mobile terminals or base stations. One of the most power-hungry and non-linear components is the PA. The design of the power amplifier must allow it to:

- Increase spectral efficiency
- Increase power added efficiency (PAE)
- Reduce distortion and non-linearity

Techniques such as crest factor reduction, envelope tracking and digital pre-distortion, can be implemented to increase PA efficiency. All of these methods are supported by the N7614B Signal Studio for power amplifier test software.

Crest Factor Reduction Technology

CFR is a technique used to reduce the peak-to-average power ratio (PAPR) of the transmitted signals so that the power amplifier can operate more efficiently. There are two CFR algorithms supported by N7614B.

- Clipping and filtering
- Peak windowing (Kaiser window)
- Peak cancellation

Digital Pre-Distortion Technology

Power amplifiers with high PAR signals can create non-linearity problems. When a high power signal is applied to the PA input, the PA can't linearly amplify the signal, possibly resulting gain saturation and distortion, and ultimately leading to signal quality degradation, such as worse ACP and EVM. DPD technology can be used to compensate for the non-linear behavior of the PA. DPD applies "inverse" distortion to the PA input signal to cancel the distortion generated by the PA. There are several types of DPD methods, including memoryless and memory, which convey the memory effect on a PA. N7614B supports the following four methods:

- Look-up table (extract or user-defined)
- Volterra series
- Memory polynomial
- Customer defined algorithms

Typical measurements

Distortion measurement

- AM-AM
- AM-PM
- CCDF

Spectrum measurement

- Channel power
- ACP

Modulation quality

- Raw EVM
- Demod EVM
- Dynamic EVM
- EVM vs. Power
(X-Series measurement applications required)

Envelope Tracking Technology

Modern modulated signals have high PAPR. Power amplifiers that must amplify these high PAPR signals, if using a fixed bias, must be operated at a relatively high output power back-off, to avoid greatly distorting the signal when the envelope excursion is near its peak. However, as the amount of back-off increases, the power amplifier becomes less efficient. Envelope tracking (ET) is the leading solution for this issue in mobile RF front end design. ET dynamically adjusts the DC supply voltage based on the “envelope” of the PA input signal and delivers higher voltages only when needed, improving battery consumption and heat dissipation in the PA. N7614B supports ET technology, which can be applied on its own, or combined with DPD. When combined with DPD, ET can be applied and optimized before or after DPD is applied. Precise timing adjustment, down to a nanosecond or a fraction of a nanosecond, is required to optimize ET system performance. N7614B software supports:

- Automatic time delay adjustments (based on ACP measurement results)
- Manual time delay adjustments (based on ACP or EVM measurement results or an external oscilloscope)

Apply your signals in real-world testing

To use N7614B Signal Studio for Power Amplifier Test software, you must have a properly configured PC and several properly configured instruments, as described here. Signal Studio software complements these platforms by providing a cost-effective way to tailor them to your test needs in design, development and production test.

Digital pre-distortion test

- Signal generators
 - X-Series signal generator - MXG, EXG (ARB or Real-time)
 - ESG
 - PSG
 - M8190A
 - PXIe M9381A
- Signal analyzers
 - X-Series signal analyzer - UXA, PXA, MXA, EXA with 89600 VSA software
 - PXIe VSA - M9391A/M9393A

Envelope tracking test

- Signal generators
 - X-Series signal generator - MXG, EXG (ARB or Real-time)
 - PXIe M9381A (PA Reference Solution, support by API method)
- Signal analyzers
 - X-Series signal analyzer - UXA, PXA, MXA, EXA with 89600 VSA software
 - PXIe VSA - M9391A/M9393A
- Envelope signal generator
 - 33522B waveform generator
 - 33622A waveform generator
 - X-Series signal generator - MXG, EXG

Crest Factor Reduction Test

CFR is a technique used to reduce the PAPR of the transmitted signals so that the power amplifier can operate more efficiently.

N7614B Signal Studio supports three kinds of CFR algorithms:

Clipping and filtering

- Clipping and filtering, the conventional method, includes both hard clipping and low-pass filtering
- Clipping can cause sharp corners in a clipped signal, which leads to an unwanted out-of-band emission (increased ACP)
- To reduce the unwanted out-of-band emissions, the clipped signal will then go through a low-pass filter to reduce the high frequency signals which correspond to the sharp corners in the clipped signal
- Clipping and filtering methods utilize two main parameters; target PAPR and Max iteration

Peak windowing

- Peak windowing aims to smooth the sharp corners which result from hard clipping
- In the peak windowing algorithm, clipping is implemented by multiplying the original signal in the region of the peak with a windowing function such as Kaiser, Gaussian and Hamming
- The peak window method's main parameters are target PAPR, max iteration, max window length, and beta as the Kaiser window adjustment parameter

Peak cancellation

- Peak cancellation method reduces the PAPR of a signal by subtracting spectrally shaped pulses from signal peaks that exceed a specified threshold
- The peak cancellation method's main parameters are target PAPR, max iteration, and crest factor

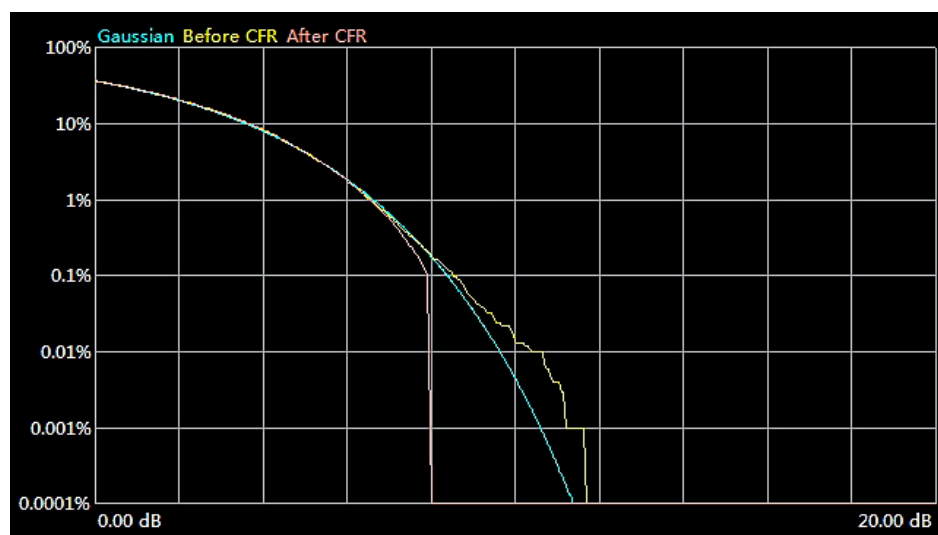


Figure 1. CCDF results traces with CCDF before CFR, CCDF after CFR, and Gaussian as reference

Before CFR ▼	
10%	3.65 dB
1%	6.55 dB
0.1%	8.50 dB
0.01%	10.65 dB
0.001%	11.65 dB
0.0001%	11.65 dB
Peak	11.65 dB
ΔEVM	--- %

Figure 2. CCDF results before CFR

After CFR ▼	
10%	3.65 dB
1%	6.50 dB
0.1%	7.90 dB
0.01%	7.95 dB
0.001%	7.95 dB
0.0001%	7.95 dB
Peak	8.00 dB
ΔEVM	2.20 %

Figure 3. CCDF results after CFR with a delta EVM result, using peak windowing

You can see that the original 802.11ac waveform with 40 MHz BW and MCS9 (Figure 2) has a peak PAPR of about 11.65 dB. With the peak windowing CFR technology (Figure 3), the PAPR is successfully reduced to 8.00 dB. However, the delta EVM deteriorated by 2.20%. CFR technology can be used independently or it can be combined with DPD technology to reduce the PAPR and compensate for the non-linear behavior of the PA.

Digital Pre-Distortion Test

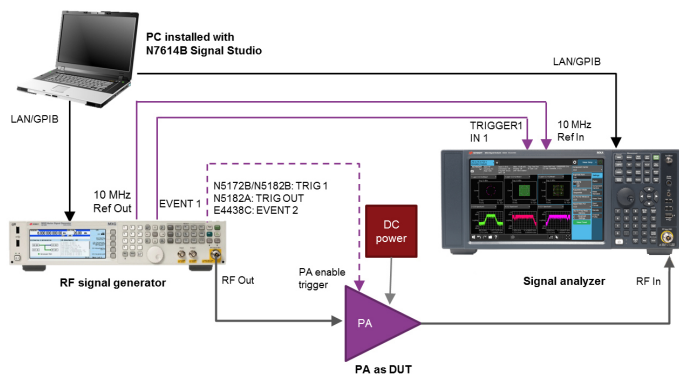


Figure 4a. Typical power amplifier DPD test configuration using N7614B Signal Studio with an MXG X-Series signal generator and an X-Series signal analyzer.

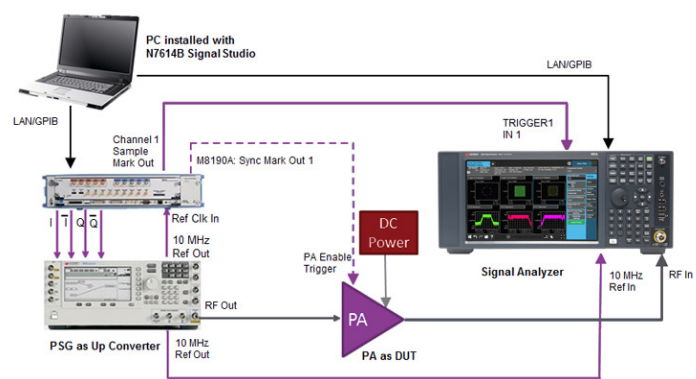


Figure 4b. Typical wideband PA test configuration using N7614B with M8190A AWG and PSG as signal generator and X-Series signal analyzer.

As discussed earlier, the PA is required to have higher linearity to amplify high PAPR signals. However, due to the limitations of cost, power consumption, and physical space, it is not easy to find higher linearity components that meet all of a particular system's requirements. DPD, one of the most cost-effective linearization techniques, adds an expanding nonlinearity in the baseband that complements the compressing characteristic of the RF power amplifier (Figure 5). Ideally, the cascade of the pre-distorter and the power amplifier becomes linear and the original input is amplified by a constant gain. With the pre-distorter, the power amplifier can be utilized up to its saturation point while still maintaining good linearity, thereby significantly increasing its efficiency (Figure 6).

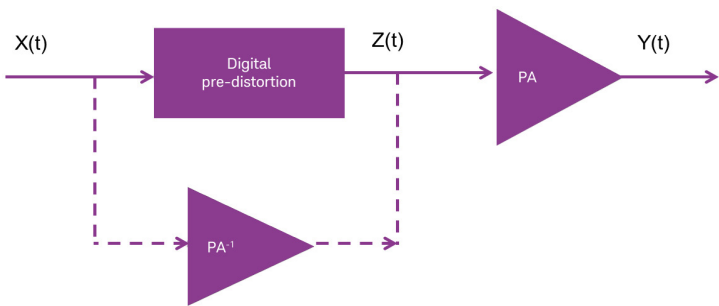


Figure 5. DPD for a PA cascade

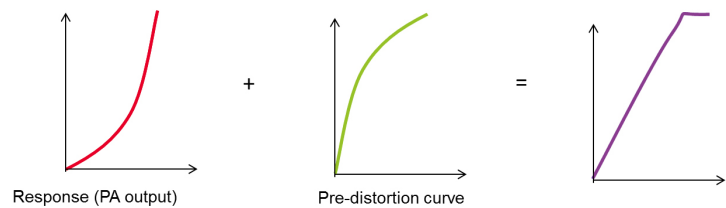


Figure 6. PA response with DPD

As shown in Figure 6, the DPD can be seen as an “inverse” of the PA. The DPD algorithm needs to model the PA behavior accurately and efficiently for successful DPD deployment.

N7614B Signal Studio software supports two kinds of DPD modes:

Extract and apply

- Three PA model types are supported: Memory polynomial, Volterra series and look-up table
- Users can specify the number of iterations
- For memory polynomial and Volterra series memory model types, users can specify the memory order and non-linear order
- The DPD model can be exported for further verification
- Customer’s proprietary DPD algorithm written in MATLAB

Apply only

- For Look-Up-Table:
 - User provides the AM In (V) – AM Out (V) shaping and AM (V) – PM Out (deg) shaping table
 - Support the LUT table edition directly with GUI
 - Support the LUT table open and save
- For Memory polynomial and Volterra, supports coefficient file import

The required measurement bandwidth for acquiring signals will be determined by the bandwidth to be optimized. For example, to cover the channel adjacent to a 20 MHz LTE signal or 20 MHz 802.11n/ac signal, 60 MHz bandwidth must be available for capture. The PXIe VSAs, PXA and MXA X-Series signal analyzers support a maximum 160 MHz bandwidth, which provides bandwidth for analyzing DPD-applied waveforms up to 40 MHz LTE or WLAN signals.

Wideband DPD

For LTE 3CC/5CC or WLAN 80/160 MHz signals, the DPD algorithm requires more signal generator and signal analyzer bandwidth. We recommend a combination of the Keysight M8190A AWG, E8267D PSG and N9040B UXA as an ideal solution for wideband DPD measurement. Through the 89600 VSA software, the oscilloscope can be connected at the receiver side and wider bandwidth can be supported. Please note that for wideband systems up to the mmWave frequency band, calibration is usually needed. A tool for automatic calibration is provided in Signal Studio.

Dual-band DPD and ET

For LTE non-contiguous carrier aggregation (CA) and WLAN non-contiguous 80 MHz + 80 MHz signal creation where the two band signals are separated up to several hundred MHz, the two signals cannot be created by one signal generator. Additionally, there may be cross modulation of two signals. In this case a dual-band DPD algorithm should be applied, which will measure each band separately and build the DPD model of each band considering the cross modulation.

For dual-band ET, only one signal generator is used and the ET signal is derived from the dual-band signal according to the different possible algorithms.

Customer provided IP DPD

N7614B also supports the customer’s DPD algorithm code written in MATLAB. The customer can modify their code in the MATLAB environment and run it directly in N7614B software. All instrument connection and data processing will be done automatically in N7614B software.

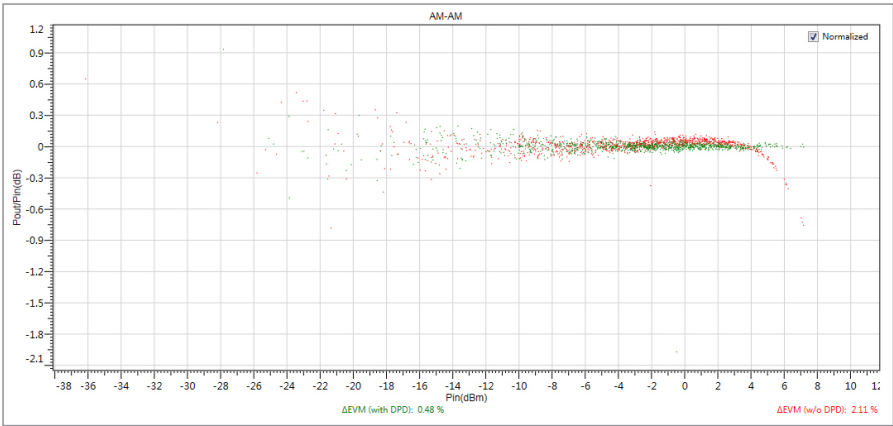


Figure 7. PA AM-AM result for 802.11n 20 MHz MCS7 using DPD memory polynomial

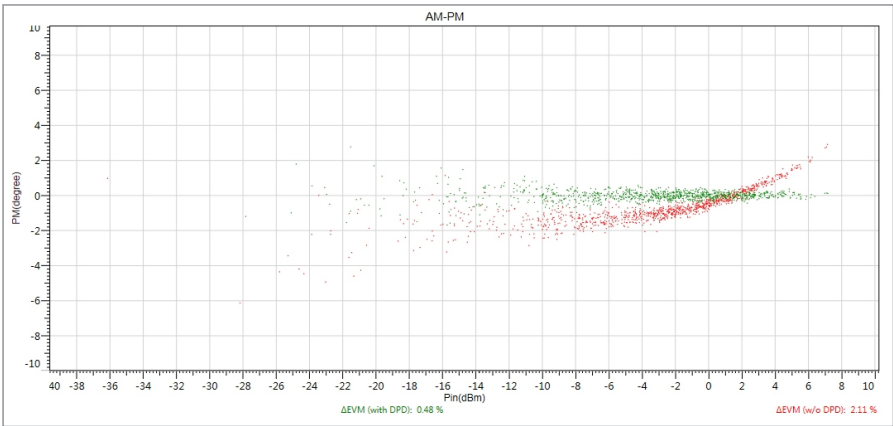


Figure 8. PA AM-PM result for 802.11n 20 MHz MCS7 using DPD memory polynomial

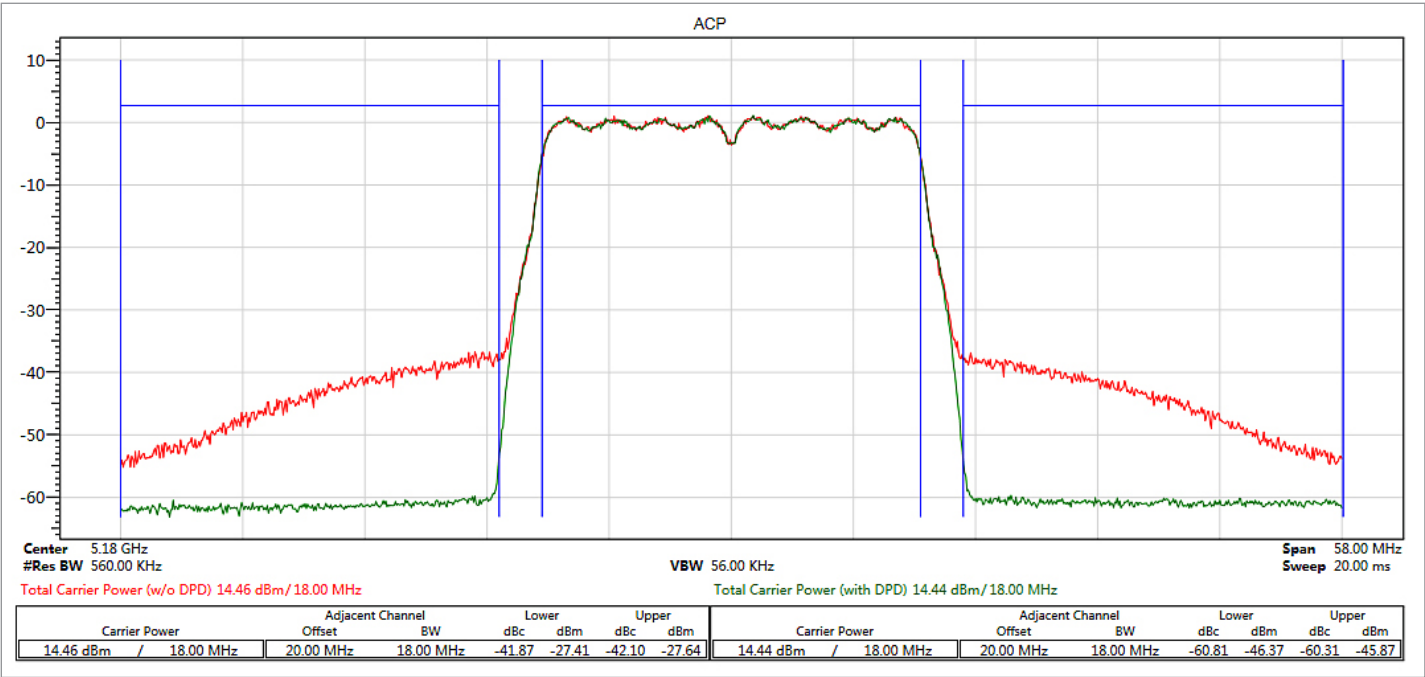


Figure 9. PA ACP result for 802.11n 20 MHz MCS7 using DPD memory polynomial

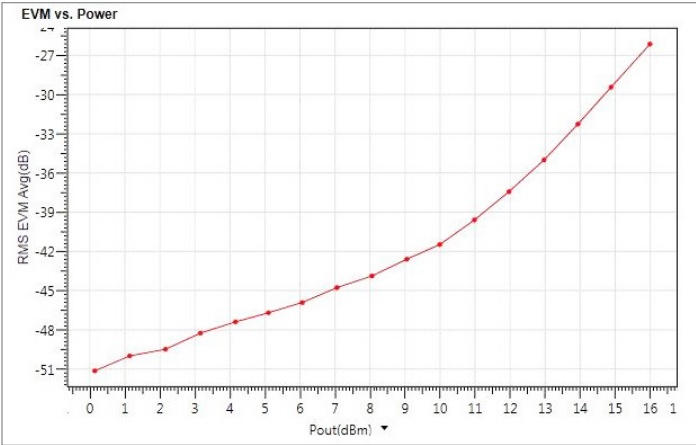


Figure 10a. WLAN 802.11n 20 MHz EVM versus Power without DPD

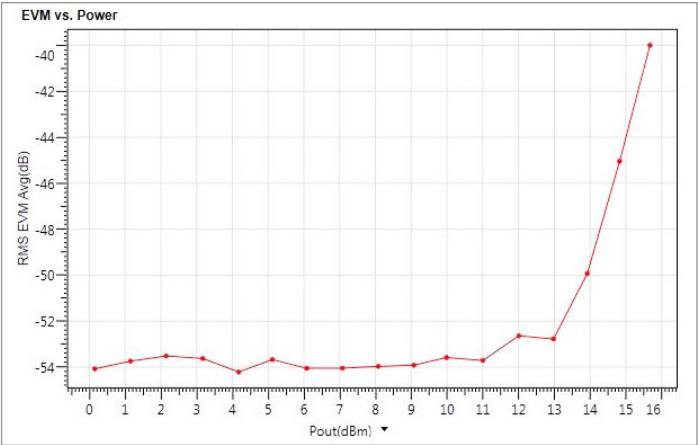


Figure 10b. WLAN 802.11n 20 MHz EVM versus Power with DPD

Envelope Tracking Test

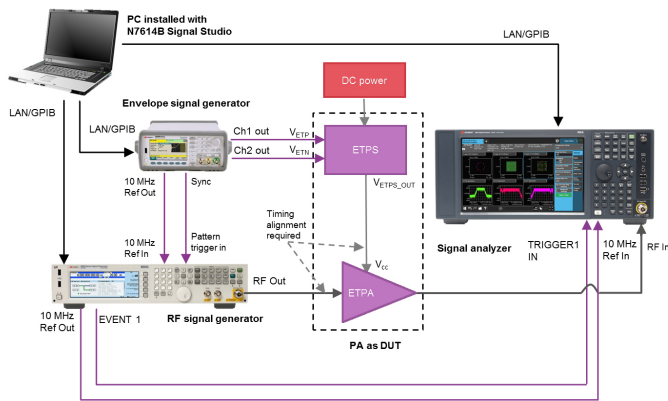


Figure 11a. Typical PA ET/ET+DPD test configuration using N7614B Signal Studio with an MXG X-Series signal generator and an X-Series signal analyzer

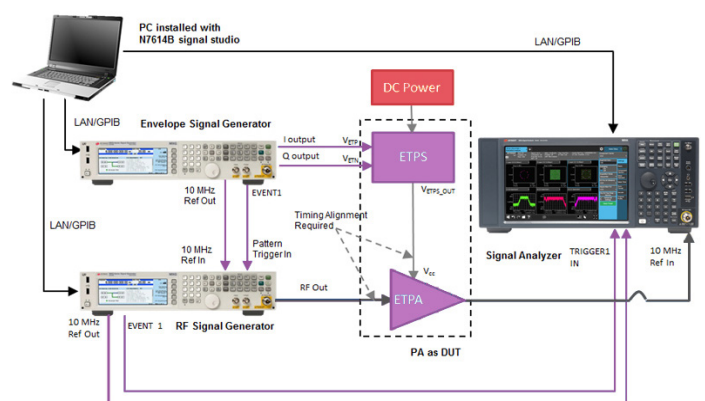


Figure 11b: PA ET/DPD test configuration using N7614B with dual MXG X-Series signal generator and X-Series signal analyzer

Envelope tracking is an adaptive power control scheme for RF power amplifiers in which the RF PA power supply (VCC_PA) is dynamically adjusted to match the envelope of the transmit signal.

Envelope tracking provides two key system benefits:

- Maximum RF PA efficiency for longer battery life and usage time
- Maximum RF PA heat reduction

Oversampling

The envelope is generated from the IQ sample's absolute magnitude, typically with 3x to 6x oversampling applied in order to create a wider bandwidth waveform. The basic sample rate of a 20 MHz LTE signal is 30.72 MHz and the envelope's sample rate will be 92.16 MHz for 3x oversampling and 184.32 MHz for 6x oversampling. A high sample rate waveform generator is required to support these high sample rates.

Shaping table

Raw envelope data generated from the IQ signal will go through the shaping table before being applied to the ET power supply (ETPS). Typically, the shaping table has a so-called "de-troughing" function to avoid having the envelope voltage drop down to 0 V. Shaping tables are usually based on maximum efficiency operation. Another commonly used table is called Iso-Gain, in which the instantaneous supply voltage is chosen to achieve a particular constant PA gain.

Timing alignment

ETPS dynamically adjusts the power supply voltage to the PA. As defined in the MIPI™ Alliance's eTrak standard, most ETPS have differential inputs and therefore, the envelope waveform generator must have differential output. ETPS output is applied to the PA's supply line. This voltage has to be applied to the PA with precise timing relative to the input RF signal. Typically the timing alignment between RF and envelope has to be less than 1 ns. Rough timing adjustments between RF and envelope can be achieved with an oscilloscope before connecting to the ETPA and ETPS. However, due to internal delays in the ETPS and the RF PA, the final tuning has to be done with the ETPA output using parameters such as EVM or ACLR. Precise timing adjustments, down to a fraction of a nanosecond, may be required to optimize ET system performance.

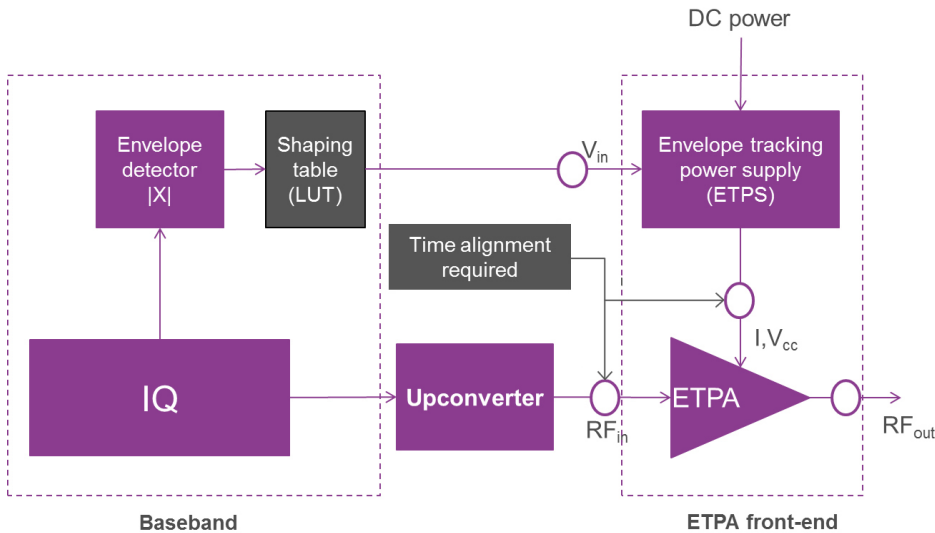


Figure 12. Envelope tracking system simplified block diagram

N7614B Signal Studio Envelope Tracking for Power Amplifier test provides:

Envelope tracking key features

- Envelope generator can use 33522B/33622A AWG or a second MXG or EXG
- Envelope calculation can be from non-predistorted I/Q signal or pre-distorted I/Q signal
- Envelope waveform can be imported from user-defined waveform
- Oversampling ratio for envelope can be user-defined
- Shaping input can be normalized I/Q amplitude or absolute RF output voltage
- Envelope waveform can be exported
- ETPS characteristic parameters can be user-defined

Shaping table

- Users provide the RF voltage to envelope voltage shaping table
- Supports the ET shaping table edition directly in the GUI
- Supports the ET shaping table open and save function
- Supports shaping table in real-time with MXG-B or EXG as envelope generator

Timing alignment

- Supports automatic alignment based on ACP measurement results
- Delay step can be settable as low as 1 ps
- Supports manual alignment based on ACP, EVM or time domain

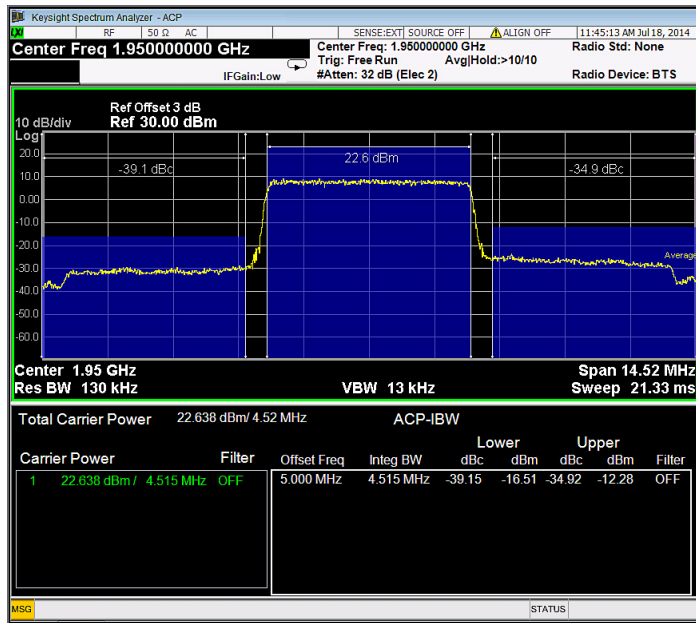


Figure 13. ET ACP measurement when time delay is not adequately adjusted

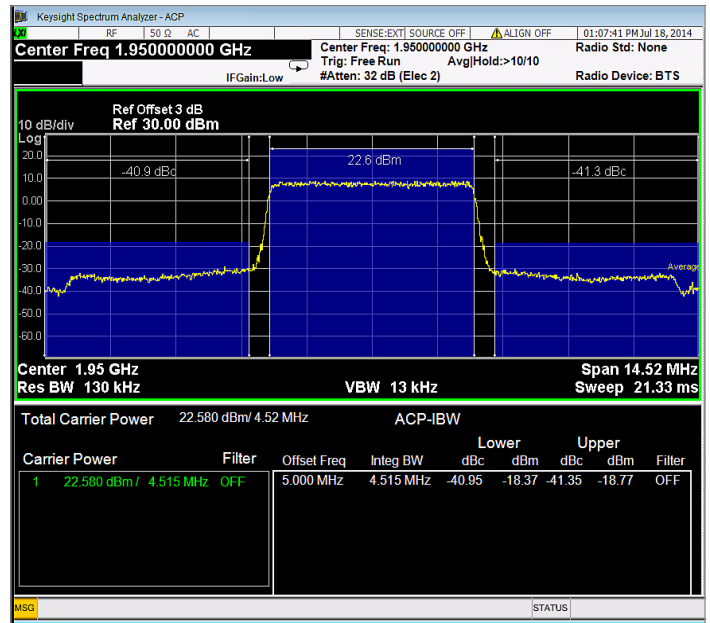


Figure 14. ET ACP measurement after automatic alignment

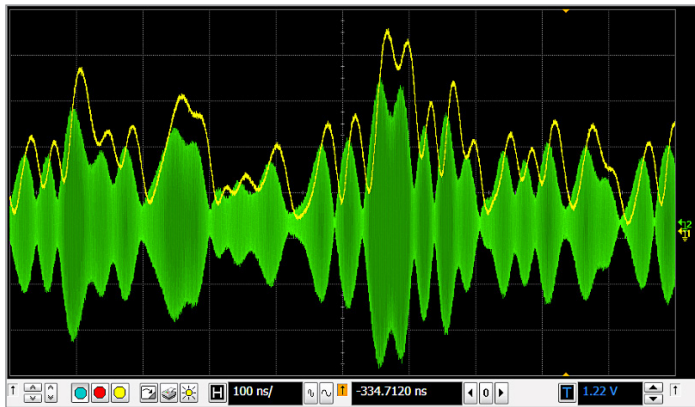


Figure 15. ET measurement in time domain when time delay is not adequately adjusted

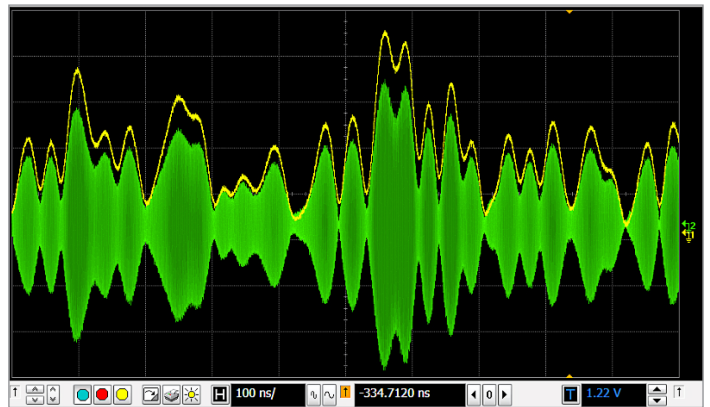


Figure 16. ET measurement in time domain after time alignment

Figures 13 and 15 illustrate what happens when the time delay between the PA RF input and the Vcc input is not adjusted adequately. The ACP measurement results will show worse, unbalanced results for the lower and upper channels. In time domain, the results may indicate that the two signals are not aligned. Automatic alignment (Figures 14 and 16) is based on an ACP measurement which is fast and convenient, but you can perform manual alignment if needed based on ACP, EVM, or time domain measurements.

Combined Use of ET and DPD

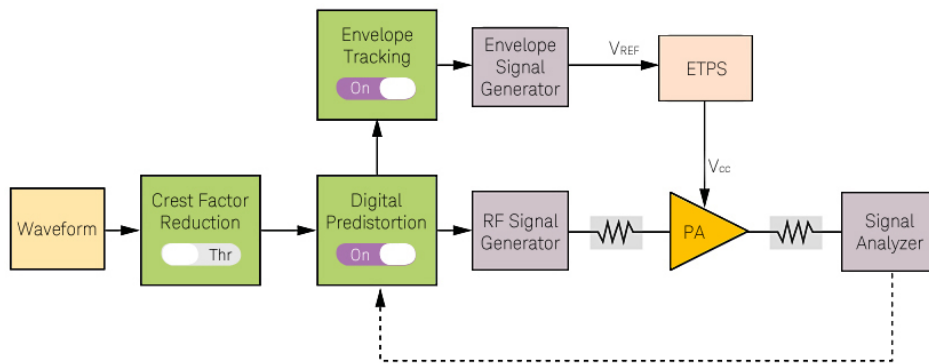


Figure 17. ET can be chosen from a non-predistorted waveform or pre-distorted waveform

When applying DPD together with ET, in order to linearize AM-PM characteristics, the envelope is typically generated based on pre-distorted I/Q waveforms. This means that for each DPD closed-loop iteration, both the pre-distorted I/Q waveform and the envelope waveforms need to be re-generated based on the updated DPD model. In order to understand if performance improvements are due to ET or DPD, ET can be applied and optimized before DPD, and then a DPD closed-loop iteration can be performed to compensate for amplitude and phase non-linearity.

N7614B Signal Studio software has integrated GUI support for both ET and DPD. It can generate an envelope from a pre-distorted waveform or a non-predistorted waveform. If the envelope source is chosen from a non-predistorted signal, the envelope will be calculated before DPD is applied. If the envelope source is chosen from a pre-distorted signal, DPD will be extracted and applied first, after which the envelope is calculated based on a pre-distorted waveform. The process will be repeated for a specified number of iterations.

Measurement

Figure 18 shows an example of 5 MHz LTE uplink with QPSK modulation. The original waveform has an ACP result of -36 dBc and the AM-AM trace shows that the PA 1 dB compression point happens at +1 dBm PA input. After ET technology is applied, you can see that the AM-AM and AM-PM traces are linearized and ACP is improved from -36 dBc to -41 dBc. When DPD technology is applied, together with ET, the AM-AM and AM-PM curves are further linearized and ACP results will be further improved from -41 dBc to -64 dBc.

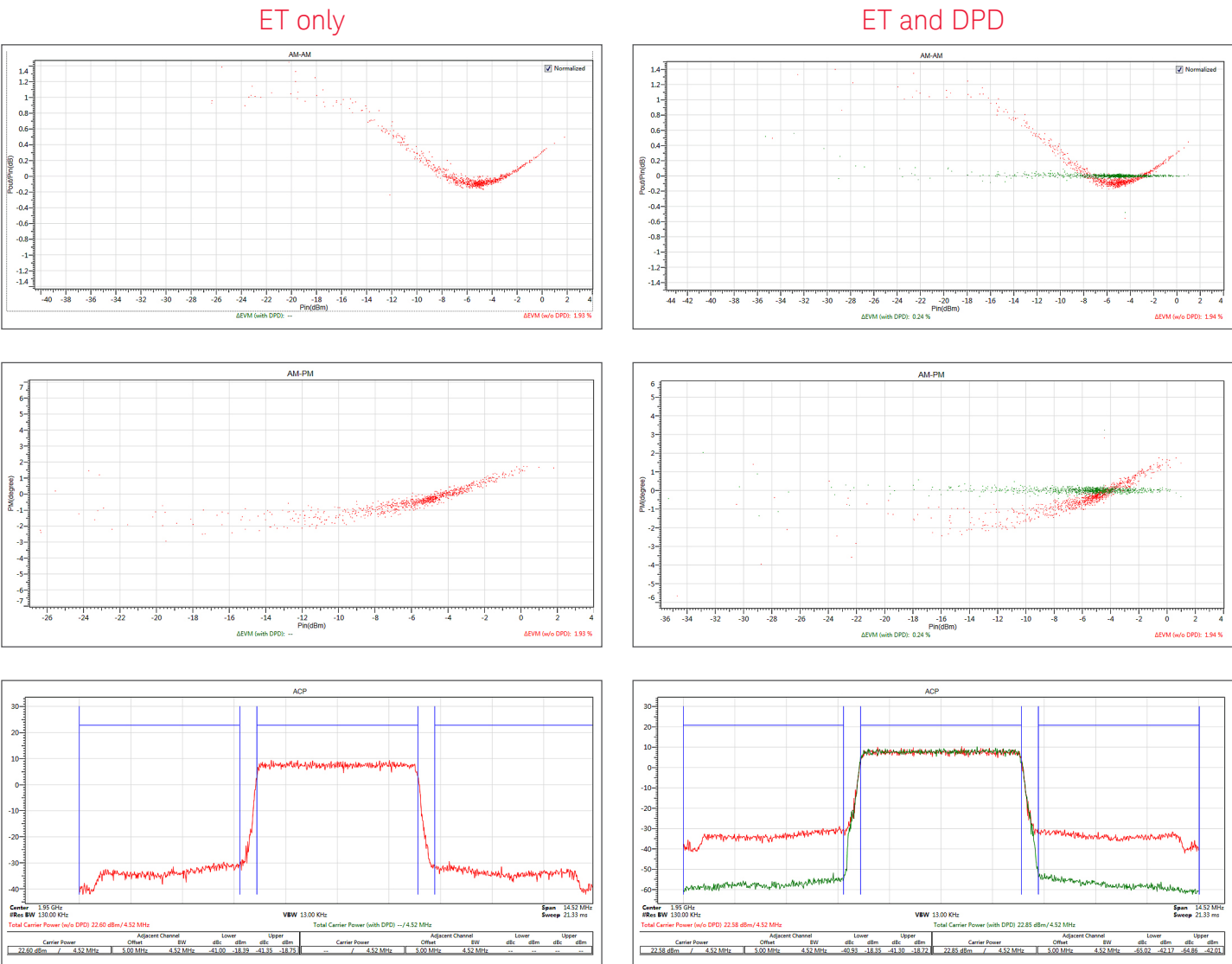


Figure 18. These graphs show the effect of ET only and ET with DPD with AM-AM, AM-PM and ACP results

Feature Summary

Power Amplifier Test		
Signal Studio	Parameter settings	Outputs or measurements
General	<ul style="list-style-type: none"> Hint for each module Instrument connection by LAN or GPIB Instrument key parameter settings on N7614B GUI 	<ul style="list-style-type: none"> Hint for each measurement Log information for the running results
Waveform	<ul style="list-style-type: none"> Preloaded, Signal Studio or user-defined User defined types: <ul style="list-style-type: none"> CSV or text files Big Endian 16 bits MATLAB Set the OSR (oversampling rate for waveform) Burst formation mask setting for WLAN Marker source selection <ul style="list-style-type: none"> None Waveform start From the input WFM file PA enable mask User defined bits 	
Power amplifier	<ul style="list-style-type: none"> Set PA related parameters like loss In, loss Out, PA gain Choose the power control <ul style="list-style-type: none"> PA input PA output Power sweep setting for dynamic EVM 	
Crest factor reduction	<ul style="list-style-type: none"> Support two CFR algorithms <ul style="list-style-type: none"> Peak windowing Clipping and filtering Peak cancellation 	<ul style="list-style-type: none"> CCDF table (Before CFR) CCDF table (After CFR) Delta EVM CCDF trace (before CFR, after CFR and Gaussian as reference)
Digital pre-distortion	<ul style="list-style-type: none"> Support two method: <ul style="list-style-type: none"> Extract and apply Apply I/Q LUT Extract and apply support four kinds of PA modeling types: <ul style="list-style-type: none"> Memory polynomial Volterra series Look-up table (memoryless model) User-defined MATLAB script Apply user-defined DPD models Wideband DPD support using M8190A AWG as baseband generator and E8267D as up-converter or M8190A DUC mode Dual-band DPD 	<ul style="list-style-type: none"> Export pre-distorted waveform Export DPD model to CSV file AM-AM trace AM-PM trace Delta EVM results (with or without DPD) ACP trace and result metrics EVM vs. Power (Raw EVM, Dynamic EVM, WLAN EVM or LTE EVM)
Envelope tracking	<ul style="list-style-type: none"> Envelope calculation support three kinds of input: <ul style="list-style-type: none"> From non-predistorted signal From pre-distorted signal User defined OSR (oversampling rate) for envelope can be set with default 3x OSR Shaping input support: <ul style="list-style-type: none"> Normalized I/Q amplitude Absolute RF output voltage Shaping table <ul style="list-style-type: none"> Open/save Add/remove Edition on GUI Timing alignment: <ul style="list-style-type: none"> Automatically Manually Shaping table can be applied in real-time if using the MXG-B N5182B or EXG N5172B as envelope generator 	<ul style="list-style-type: none"> AM-AM trace AM-PM trace Delta EVM results ACP trace and result metrics EVM vs. Power (Raw EVM, Dynamic EVM, WLAN EVM or LTE EVM) Dual-band ET

Ordering Information

Software licensing and configuration

Signal Studio offers flexible licensing options, including:

- **Fixed license:** Allows you to create unlimited I/Q waveforms with a specific Signal Studio product and use them with a single, specific platform.
- **Transportable/floating license:** Allows you to create unlimited I/Q waveforms with a specific Signal Studio product and use them with a single platform (or PC in some cases) at a time. You may transfer the license from one product to another.

The table below lists fixed, perpetual licenses only; additional license types may be available. For detailed licensing information and configuration assistance, please refer to the Licensing Options web page at www.keysight.com/find/SignalStudio_licensing

N7614B signal studio for power amplifier test

Model-Option	Description
Connectivity	
N7614B-1FP	Connect to E4438C ESG signal generator
N7614B-3FP	Connect to N5182B/72B MXG/EXG signal generator
N7614B-9FP	Connect to M9381A PXIe vector signal generator
N7614B-AFP ¹	Connect to M8190A arbitrary waveform generator
Capability	
N7614B-EFP	Envelope Tracking
N7614B-FFP ²	Digital Pre-Distortion
N7614B-GFP ^{3,4}	Real-time envelope tracking and digital pre-distortion
N7614B-HFP	Wideband DPD with calibration ⁵

1. M8190A support using PSG as up-converter or DUC mode.
2. For dual-band DPD, both of the signal generators need FFP license.
3. For real-time DPD, the MXG or EXG RF signal generator requires Option 660.
4. For real-time ET, both the RF signal generator and envelope generator require the GFP license.
5. Option HFP requires option FFP.

Try Before You Buy!

Free 30-day trials of Signal Studio software provide unrestricted use of the features and functions, including signal generation, with your compatible platform. Redeem a trial license online at

www.keysight.com/find/free_trials

Hardware configurations

To learn more about compatible hardware and required configurations, please visit: www.keysight.com/find/SignalStudio_platforms

PC requirements

A PC is required to run Signal Studio. www.keysight.com/find/SignalStudio_pc

Additional Information

Websites

Access the comprehensive online documentation, which includes the complete software HELP, download the software, and request a trial license.

www.keysight.com/find/n7614b
www.keysight.com/find/SignalStudio

Keysight's ET and DPD test solutions
www.keysight.com/find/ET
www.keysight.com/find/DPD

Keysight's RF PA/FEM characterization and test reference solution with ET and DPD
www.keysight.com/find/solution-padv

Literature

Simulation and Measurement-based X-parameter Models for Power Amplifiers with Envelope Tracking, 5991-2733EN

Envelope Tracking and Digital Pre-Distortion Power Amplifier Testing for LTE User Terminal Components, 5991-4069EN

Signal Studio Software, Brochure, 5989-6448EN

Signal Studio for LTE/LTE-Advanced FDD and TDD, Technical Overview, 5990-6086EN

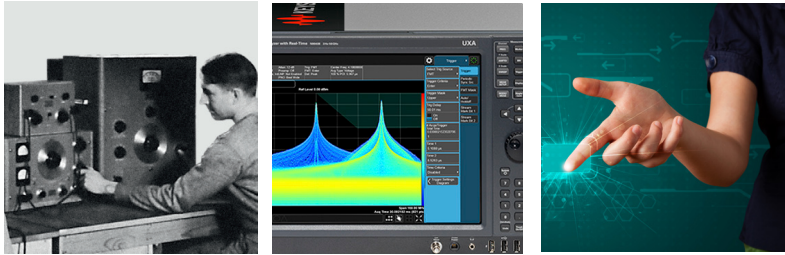
Signal Studio for WLAN 802.11a/b/g/n/ac, Technical Overview, 5990-9008EN

RF PA/FEM Characterization & Test, Reference Solution, Brochure, 5992-0071EN

RF PA/FEM Characterization & Test, Reference Solution, Configuration Guide, 5992-0072EN

Evolving

Our unique combination of hardware, software, support, and people can help you reach your next breakthrough. **We are unlocking the future of technology.**



From Hewlett-Packard to Agilent to Keysight



myKeysight	<p>myKeysight</p> <p>www.keysight.com/find/mykeysight</p> <p>A personalized view into the information most relevant to you.</p>
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